

5SJA 3000L520300

StakPak BIGT Module

$$V_{CE} = 5200 \text{ V}$$

$$I_C = 3000 \text{ A}$$

Low-loss, rugged BIGT chip
 Optimized for low switching frequency
 Smooth switching for good EMC
 High tolerance to uneven mounting pressure
 Explosion resistant package
 Remains in low impedance state for up to 1 minute after failure*



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0 \text{ V}$, $T_{vj} \geq 25 \text{ }^\circ\text{C}$		5200	V
DC collector current	I_C	$T_C = 108 \text{ }^\circ\text{C}$, $T_{vj} = 125 \text{ }^\circ\text{C}$		3000	A
Peak collector current	I_{CM}	$t_p = 1 \text{ ms}$		6000	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_C = 25 \text{ }^\circ\text{C}$, $T_{vj} = 125 \text{ }^\circ\text{C}$		55500	W
DC forward current	I_F			3000	A
Peak forward current	I_{FRM}	$t_p = 1 \text{ ms}$		6000	A
Peak diode recovery power	P_{prec}	$V_{CC} \leq 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$, $T_{vj} = 125 \text{ }^\circ\text{C}$, $di/dt = 7.5 \text{ kA}/\mu\text{s}$, $L_G = 150 \text{ nH}$, inductive load		7.5	MW
Surge current	I_{FSM}	$V_R = 0 \text{ V}$, $T_{vj} = 125 \text{ }^\circ\text{C}$, $V_{GE} = 0 \text{ V}$, $t_p = 10 \text{ ms}$, half-sinewave, 3 times during lifetime		42000	A
BIGT turn off SOA (IGBT mode)	RBSOA	$V_{CC} \leq 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$, $T_{vj} = 125 \text{ }^\circ\text{C}$, $V_{GE} = 15 \text{ V}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $L_G = 150 \text{ nH}$, inductive load		6000	A
BIGT turn off SOA (IGBT mode)	RBSOA	$V_{CC} \leq 3800 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$, $T_{vj} = 125 \text{ }^\circ\text{C}$, $V_{GE} = 15 \text{ V}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $L_G = 150 \text{ nH}$, inductive load		3000	A
BIGT short circuit SOA	t_{psc}	$V_{CC} = 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$ $V_{GE} \leq 15 \text{ V}$, $T_{vj} \leq 125 \text{ }^\circ\text{C}$		10	μs
Junction temperature	T_{vj}		5	150	$^\circ\text{C}$
Junction operating temperature	$T_{vj(op)}$		5	125	$^\circ\text{C}$
Case temperature	T_C		5	70	$^\circ\text{C}$
Storage temperature	T_{stg}		-40	70	$^\circ\text{C}$
Mounting force ^{2) 3)}	F_M		60	90	kN

¹⁾ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

²⁾ For detailed mounting instructions refer to ABB document no. 5SYA 2037-02

³⁾ All electrical characteristics are valid only when the module is clamped

* Functionality is load profile dependent and needs to be agreed upon

IGBT characteristic values ⁴⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}$, $I_C = 10 \text{ mA}$, $T_{vj} = 25 \text{ }^\circ\text{C}$	5200			V
Collector-emitter ⁵⁾ saturation voltage	$V_{CE \text{ sat}}$	$I_C = 3000 \text{ A}$, $V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$	2.73		V
			$T_{vj} = 125 \text{ }^\circ\text{C}$	3.13		V
Collector cut-off current	I_{CES}	$V_{CE} = 5200 \text{ V}$, $V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ }^\circ\text{C}$		1	mA
			$T_{vj} = 125 \text{ }^\circ\text{C}$	60	120	mA
Gate leakage current	I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$, $T_{vj} = 25 \text{ }^\circ\text{C}$	-750		750	nA
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C = 480 \text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25 \text{ }^\circ\text{C}$	5.2		7.2	V
Gate charge	Q_G	$I_C = 3000 \text{ A}$, $V_{CE} = 2800 \text{ V}$, $V_{GE} = -15 \text{ V} \dots 15 \text{ V}$		25.5		μC
Input capacitance	C_{ies}	$V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_{vj} = 25 \text{ }^\circ\text{C}$		439		nF
Output capacitance	C_{oes}			19.9		nF
Reverse transfer capacitance	C_{res}			30.0		nF
Internal gate resistor	R_{Gint}			0.104		Ω
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	760		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	880		ns
Rise time	t_r	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	420		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	420		ns
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	2760		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	3040		ns
Fall time	t_f	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	860		ns
			$T_{vj} = 125 \text{ }^\circ\text{C}$	980		ns
Turn-on switching energy	E_{on}	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	11100		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	14200		mJ
Turn-off switching energy	E_{off}	$V_{CC} = 2800 \text{ V}$, $I_C = 3000 \text{ A}$, $R_G = 1.2 \text{ } \Omega$, $C_{GE} = 330 \text{ nF}$, $V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 150 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ }^\circ\text{C}$	14100		mJ
			$T_{vj} = 125 \text{ }^\circ\text{C}$	18500		mJ
Short circuit current	I_{SC}	$t_{psc} \leq 10 \text{ } \mu\text{s}$, $V_{GE} = 15 \text{ V}$, $V_{CC} = 3400 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 5200 \text{ V}$	$T_{vj} = 125 \text{ }^\circ\text{C}$	18000		A

⁴⁾ Characteristic values according to IEC 60747 - 9

⁵⁾ Collector-emitter saturation voltage is given at chip level

Diode characteristic values ⁶⁾

Parameter	Symbol	Conditions	min	typ	max	Unit
Forward voltage ⁷⁾	V _F	I _F = 3000 A, V _{GE} = 0 V	T _{vj} = 25 °C	2.29		V
			T _{vj} = 125 °C	2.52		V
		I _F = 3000 A, V _{GE} = 15 V	T _{vj} = 25 °C	3.47		V
			T _{vj} = 125 °C	3.63		V
Peak reverse recovery current	I _{RM}		T _{vj} = 25 °C	3800		A
			T _{vj} = 125 °C	4500		A
Recovered charge	Q _r	V _{CC} = 2800 V, I _F = 3000 A, V _{GE} = ±15 V, R _G = 1.2 Ω, C _{GE} = 330 nF, di/dt = 6.9 kA/μs L _σ = 150 nH, inductive load	T _{vj} = 25 °C	5100		μC
			T _{vj} = 125 °C	7600		μC
Reverse recovery time	t _{rr}		T _{vj} = 25 °C	2680		ns
			T _{vj} = 125 °C	2840		ns
Reverse recovery energy	E _{rec}		T _{vj} = 25 °C	9500		mJ
			T _{vj} = 125 °C	14500		mJ

⁶⁾ Characteristic values according to IEC 60747 - 2

⁷⁾ Forward voltage is given at chip level

Package properties

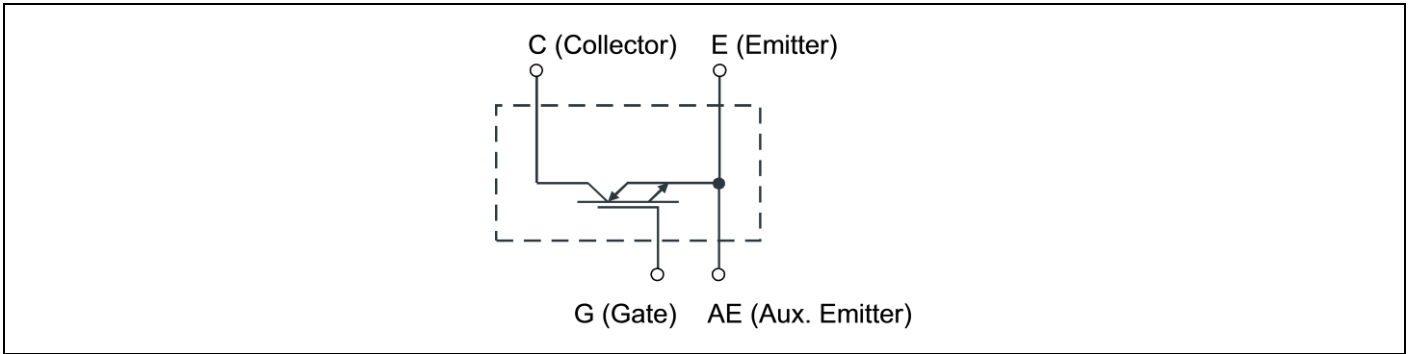
Parameter	Symbol	Conditions	min	typ	max	Unit
BIGT thermal resistance junction to case	R _{th(j-c)IGBT}				2.10	K/kW
BIGT thermal resistance ²⁾ case to heatsink	R _{th(c-h)IGBT}	Heatsink flatness : Complete module area < 100 μm Each submodule area < 20 μm Roughness : < 1.6 μm		0.55		K/kW
Comparative tracking index	CTI		600			

²⁾ for detailed mounting instructions refer to ABB Document No. 5SYA 2037-02

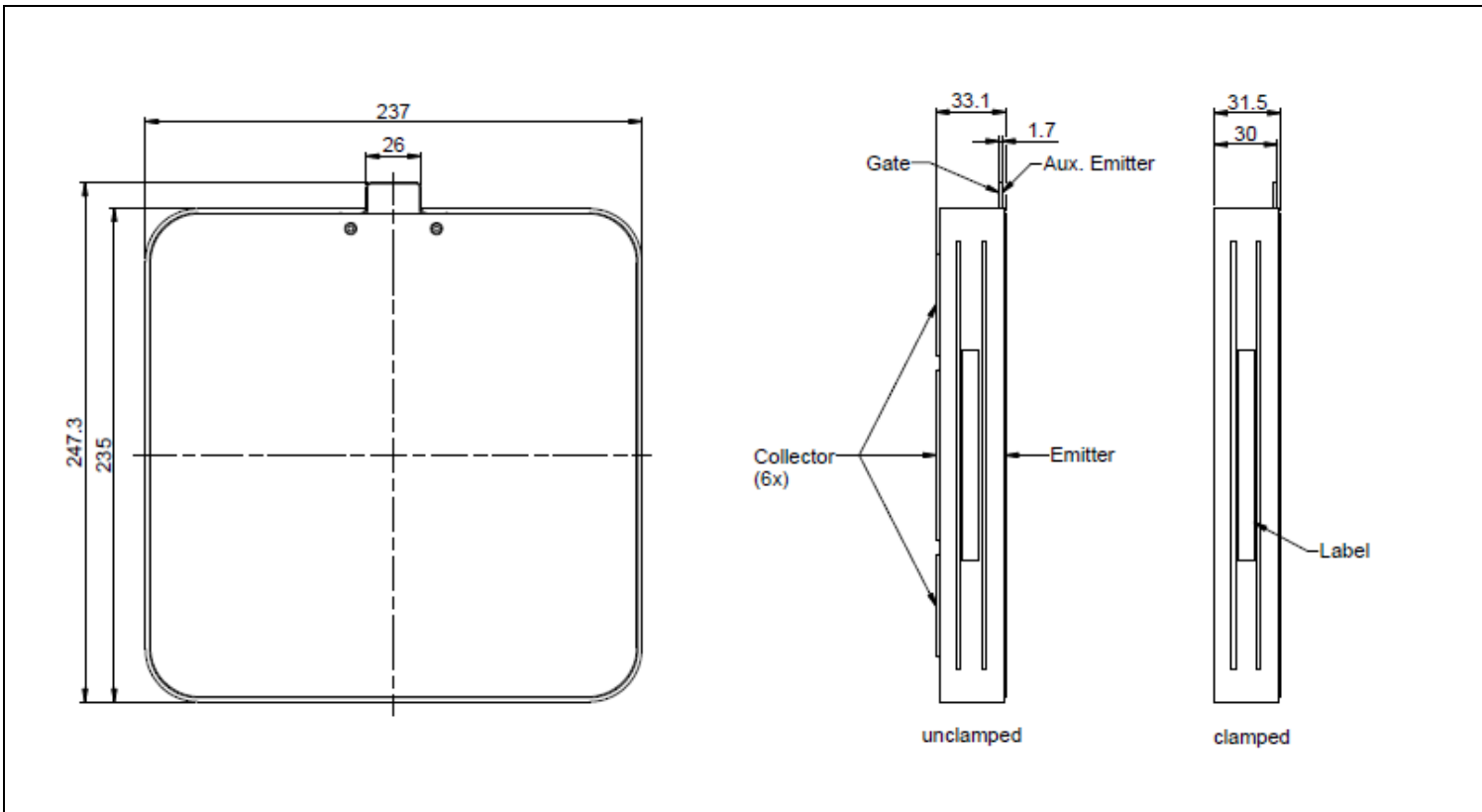
Mechanical properties

Parameter	Symbol	Conditions	min	typ	max	Unit
Dimensions	L x W x H	Typical	device clamped	237 x 250 x 31.5		mm
			device unclamped	237 x 250 x 33.2		
Clearance distance in air	d _a	according to IEC 60664-1 and EN 50124-1	23			mm
Surface creepage distance	d _s	according to IEC 60664-1 and EN 50124-1	30			mm
Mass	m			4030		g

Electrical configuration



Outline drawing ²⁾



Note: all dimensions are shown in millimeters

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA 2039

This is an electrostatic sensitive device; please observe the international standard IEC 60747-1, chap. VIII.
This product has been designed and qualified for Industrial Level.

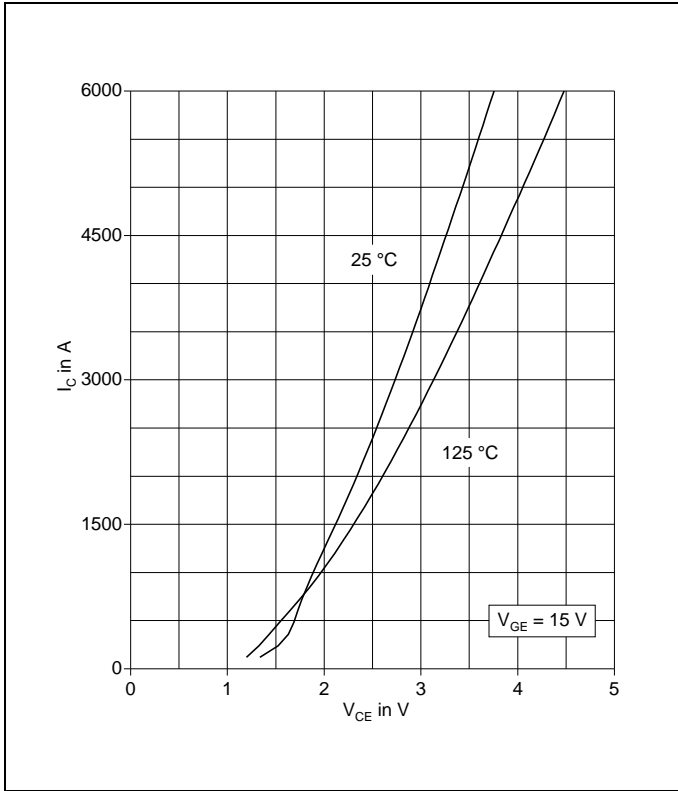


Fig. 1 Typical on-state characteristics, chip level

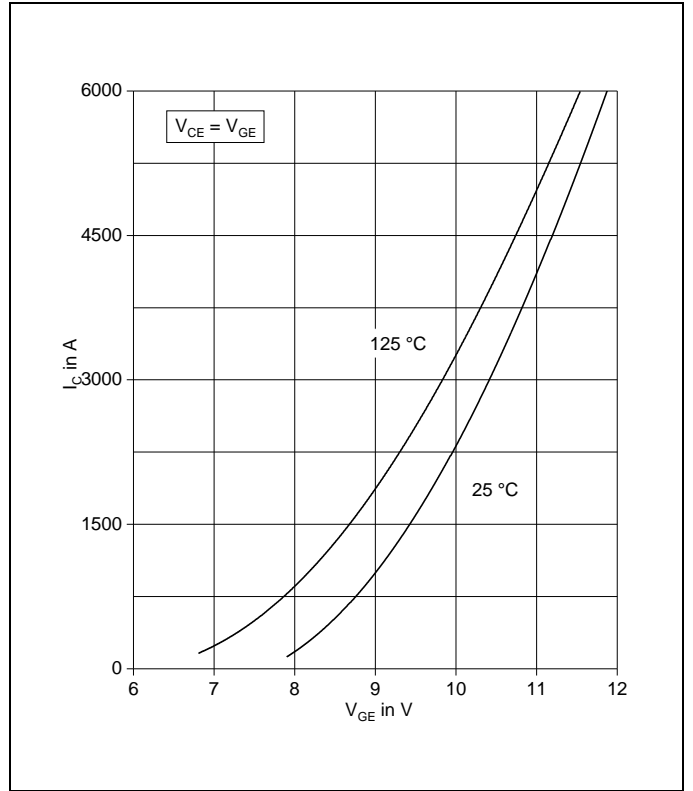


Fig. 2 Typical transfer characteristics, chip level

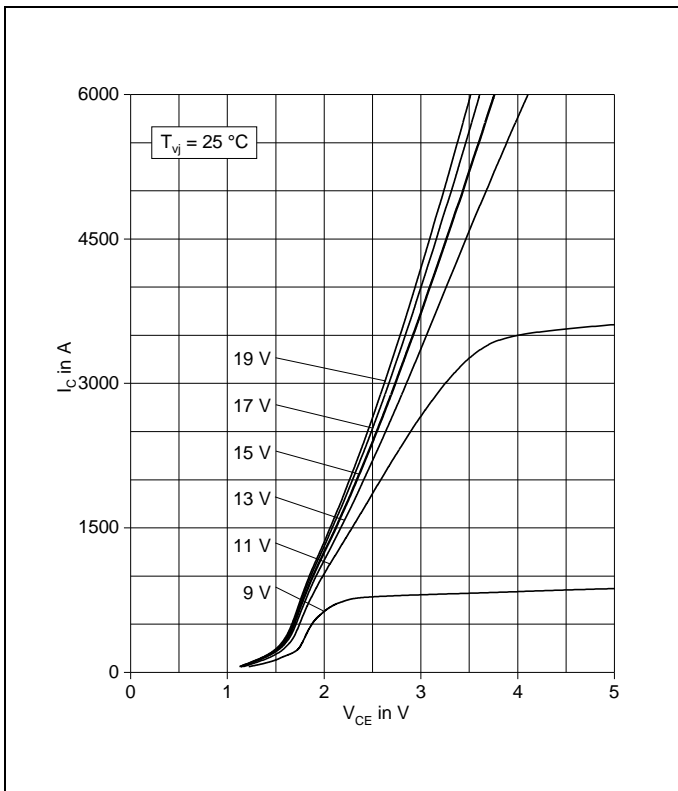


Fig. 3 Typical output characteristics, chip level

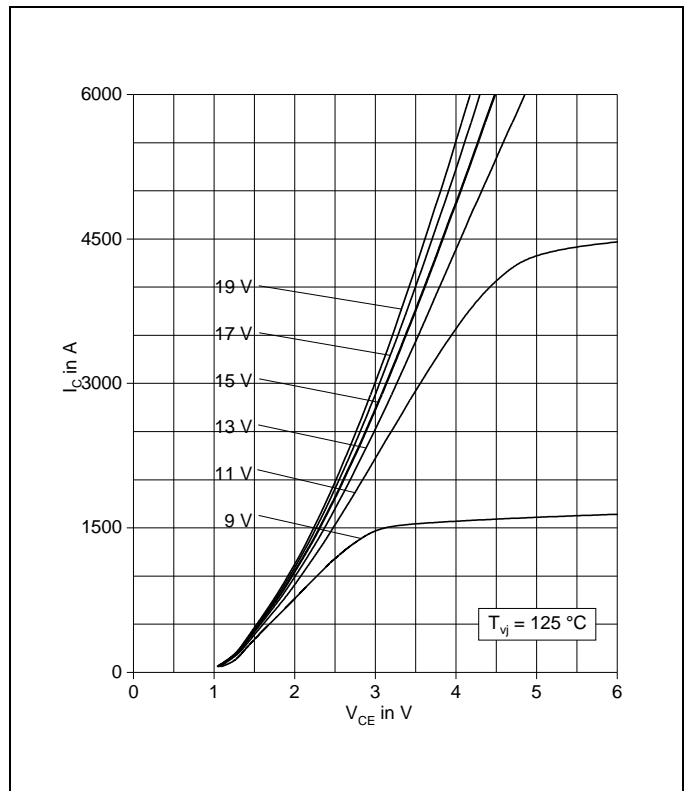


Fig. 4 Typical output characteristics, chip level

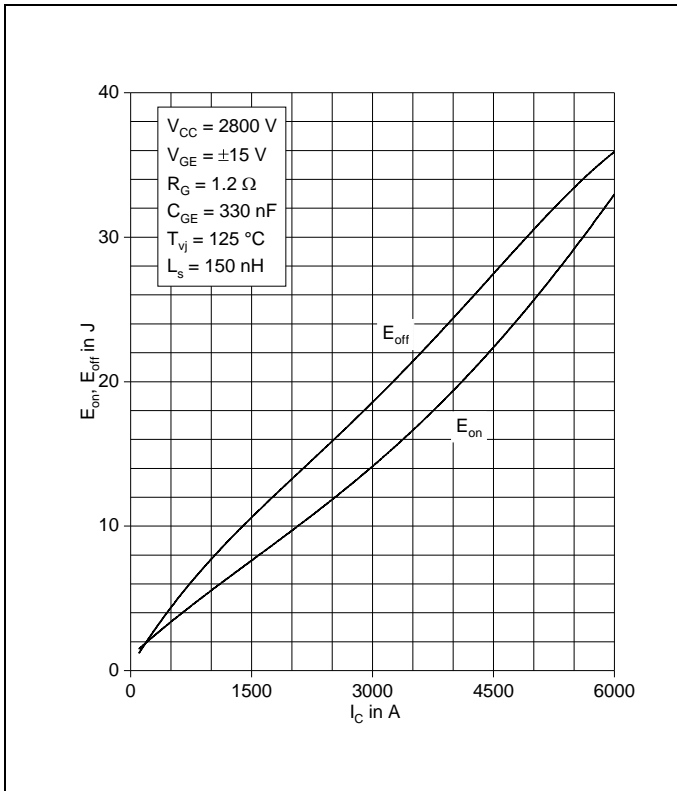


Fig. 5 Typical switching energies per pulse vs. collector current

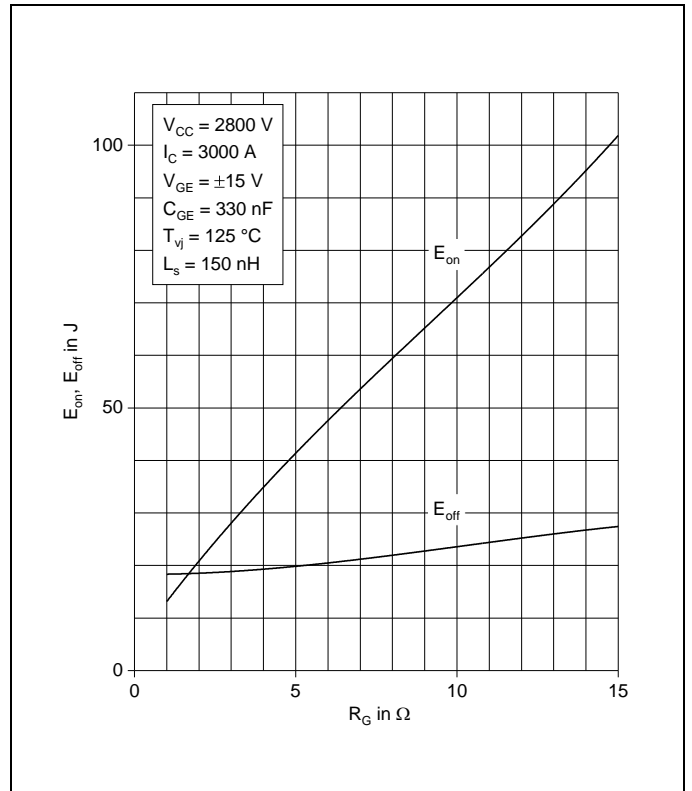


Fig. 6 Typical switching energies per pulse vs. gate resistor

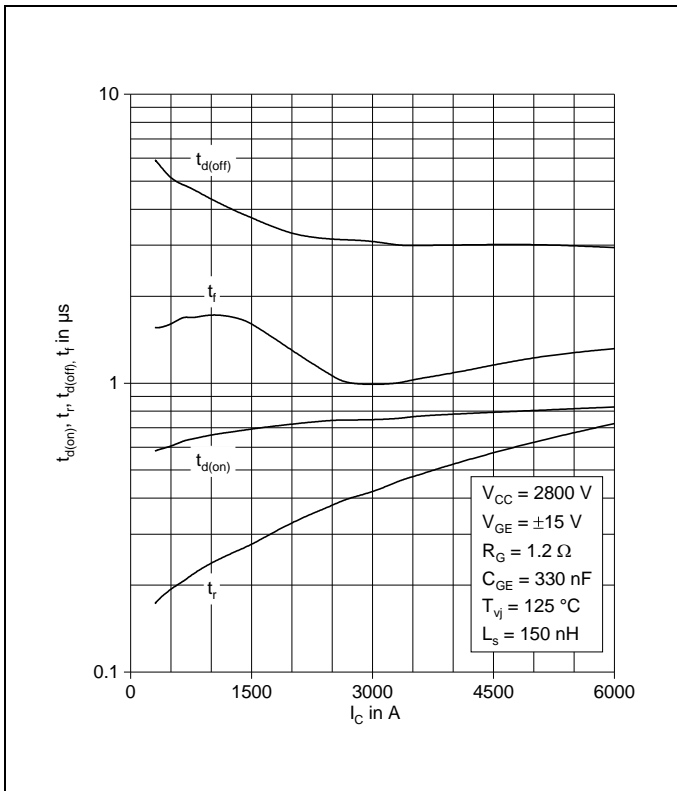


Fig. 7 Typical switching times vs. collector current

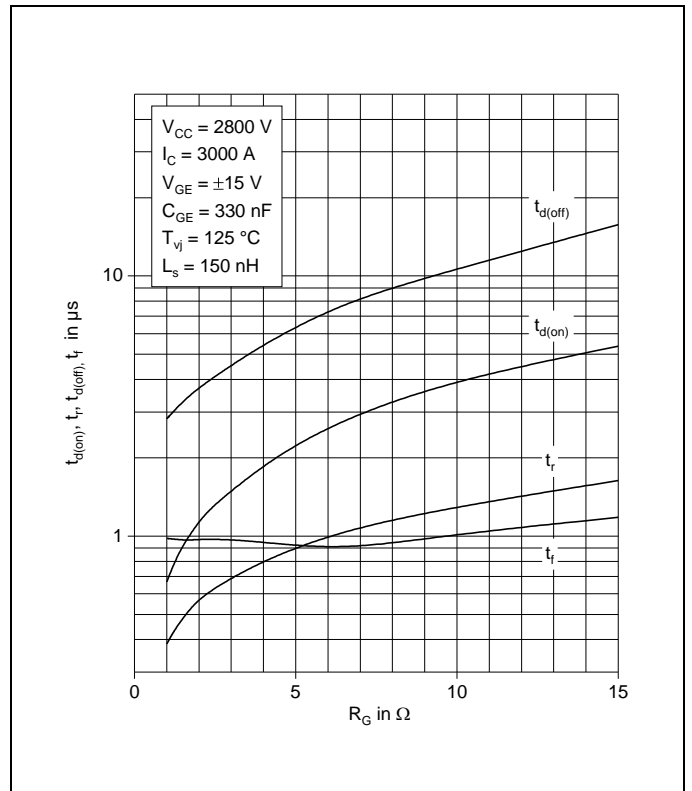


Fig. 8 Typical switching times vs. gate resistor

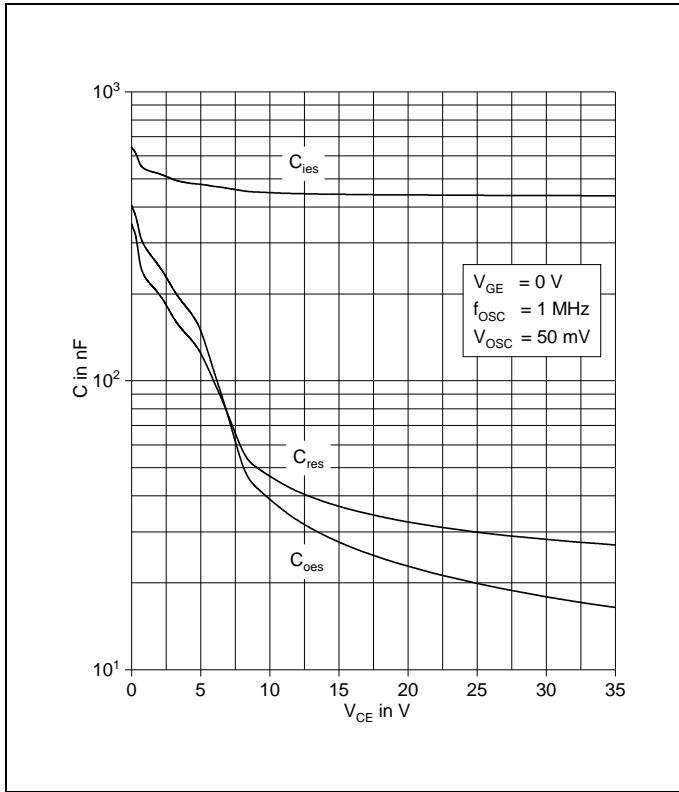


Fig. 9 Typical capacitances vs. collector-emitter voltage

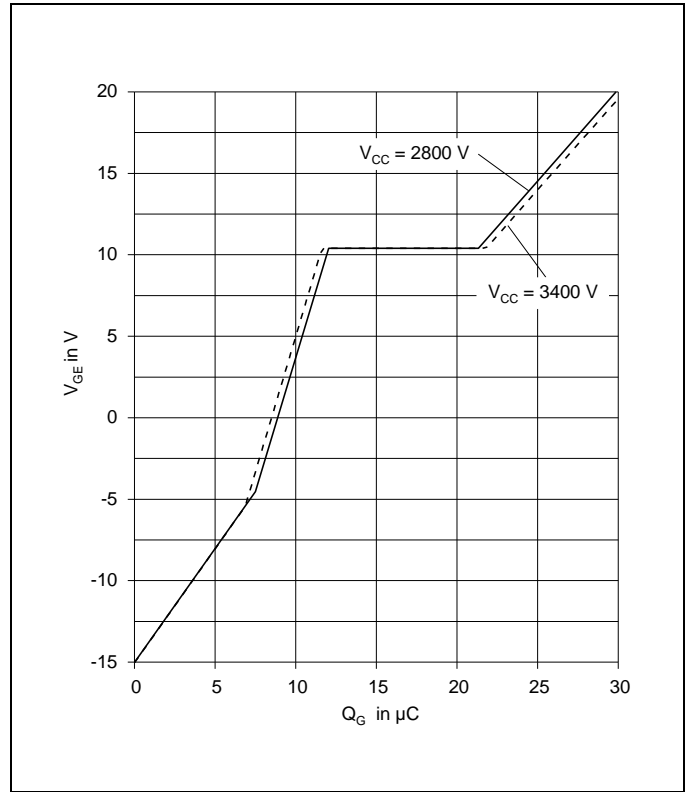


Fig. 10 Typical gate charge characteristics

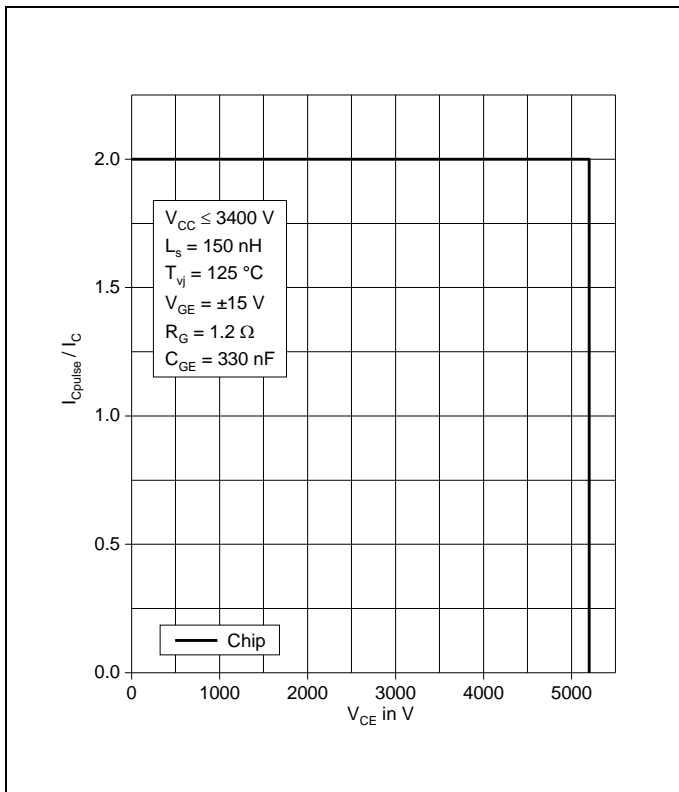


Fig. 11 Turn-off safe operating area (RBSOA)

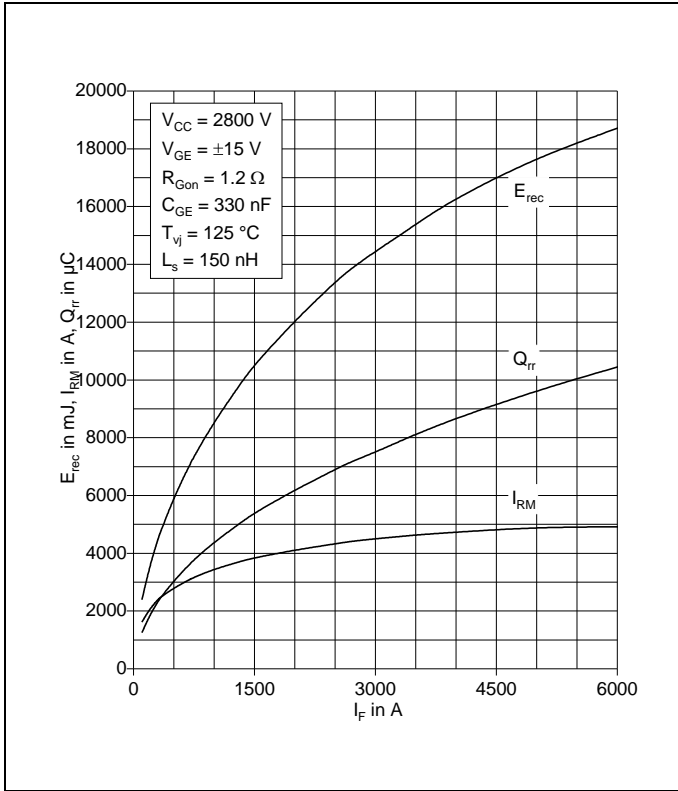


Fig. 12 Typical reverse recovery characteristics vs. forward current

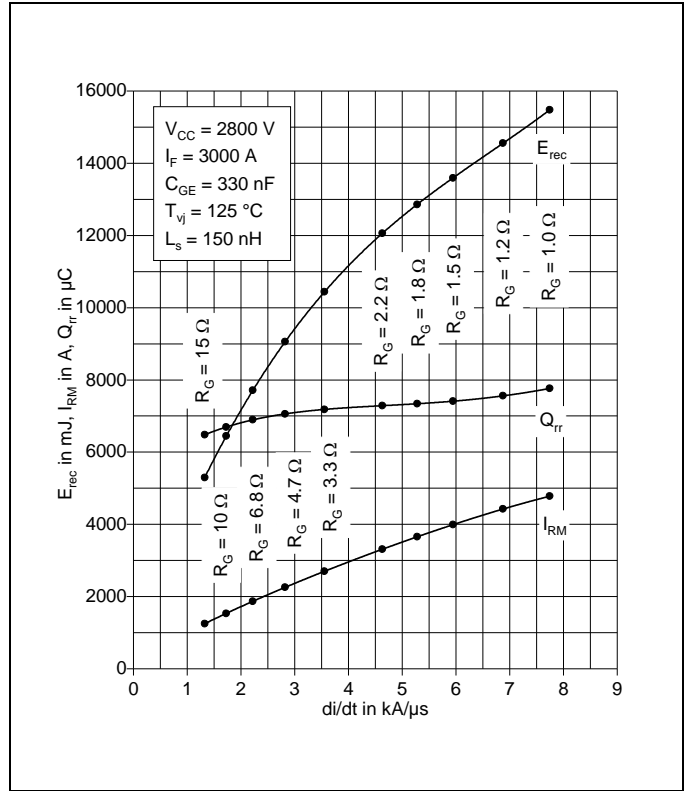


Fig. 13 Typical reverse recovery characteristics vs. di/dt

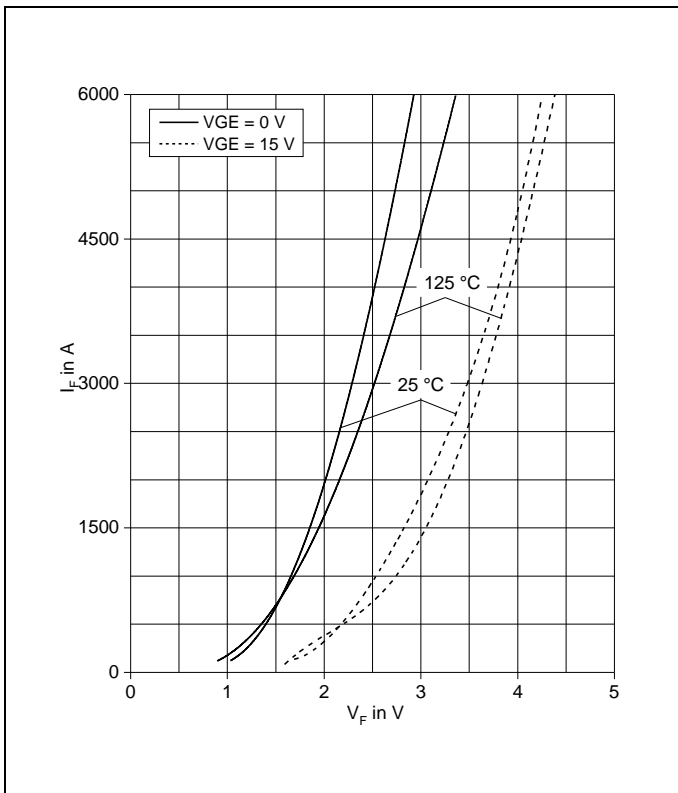


Fig. 14 Typical diode forward characteristics chip level

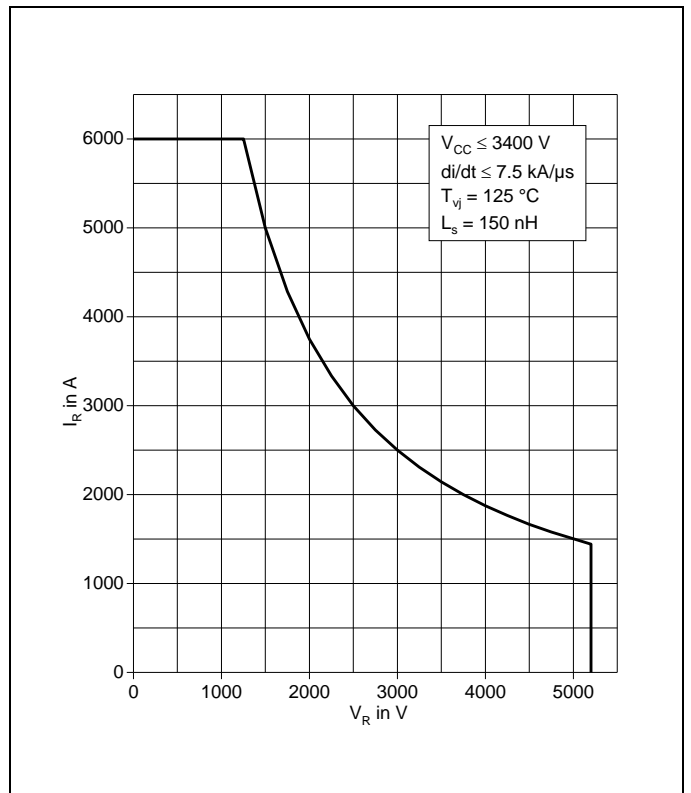


Fig. 15 Safe operating area diode (SOA)

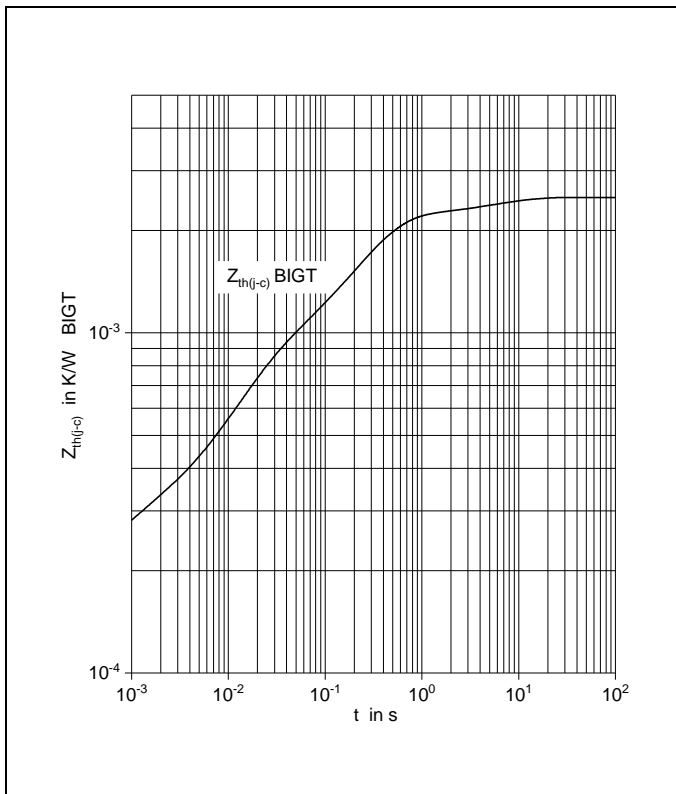


Fig. 16 Thermal impedance vs. time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/\tau_i})$$

i	1	2	3	4
R _i in K/kW	0.265	0.546	1.393	0.299
τ _i in s	0.0004	0.0168	0.2862	6.0189

Related documents:

- 5SYA 2045 Thermal runaway during blocking
- 5SYA 2053 Applying IGBT
- 5SYA 2093 Thermal design of IGBT modules

ABB Switzerland Ltd.
Semiconductors
Fabrikstrasse 3
CH-5600 Lenzburg
Switzerland

Phone: +41 58 586 1419
Fax: +41 58 586 1306
E-Mail: abbsem@ch.abb.com
Internet: www.abb.com/semiconductors

We reserve the right to make technical changes or to modify the contents of this document without prior notice.
We reserve all rights in this document and the information contained therein. Any reproduction or utilization of this document or parts thereof for commercial purposes without our prior written consent is forbidden.
Any liability for use of our products contrary to the instructions in this document is excluded.